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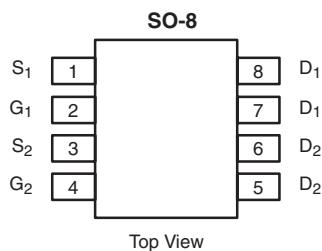
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Dual N-Channel 30-V (D-S) MOSFET

PRODUCT SUMMARY				
	V _{DS} (V)	R _{DS(on)} (Ω)	I _D (A) ^a	Q _g (Typ.)
Channel 1	30	0.0145 at V _{GS} = 10 V	10.8	8.3
		0.0195 at V _{GS} = 4.5 V	9.3	
Channel 2	30	0.0265 at V _{GS} = 10 V	7.2	4
		0.036 at V _{GS} = 4.5 V	6.2	



Ordering Information: Si4972DY-T1-E3 (Lead (Pb)-free)
Si4972DY-T1-GE3 (Lead (Pb)-free and Halogen-free)

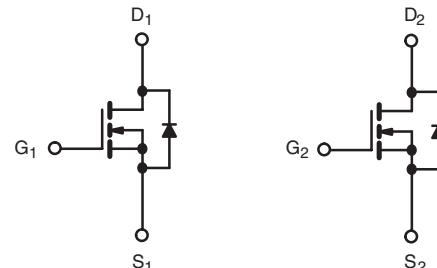
FEATURES

- Halogen-free According to IEC 61249-2-21 Available
- TrenchFET® Power MOSFET
- 100 % R_g Tested



APPLICATIONS

- Logic DC/DC for Notebook PC



N-Channel MOSFET

N-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS T_A = 25 °C, unless otherwise noted

Parameter	Symbol	Channel 1	Channel 2	Unit
Drain-Source Voltage	V _{DS}	30		V
Gate-Source Voltage	V _{GS}		± 20	
Continuous Drain Current (T _J = 150 °C)	T _C = 25 °C	I _D	10.8	A
	T _C = 70 °C		8.7	
	T _A = 25 °C		8.7 ^{b,c}	
	T _A = 70 °C		6.9 ^{b,c}	
Pulsed Drain Current (10 µs Pulse Width)	I _{DM}	20	20	
Source-Drain Current Diode Current	T _C = 25 °C	I _S	2.5	
	T _A = 25 °C		1.6 ^{b,c}	
Pulsed Source-Drain Current	I _{SM}	20	20	
Single Pulse Avalanche Current	I _{AS}	15	6	mJ
Avalanche Energy	E _{AS}	11	1.8	
Maximum Power Dissipation	T _C = 25 °C	P _D	3.1	
	T _C = 70 °C		2.1	
	T _A = 25 °C		2.0 ^{b,c}	
	T _A = 70 °C		1.25 ^{b,c}	
Operating Junction and Storage Temperature Range	T _J , T _{stg}	- 55 to 150		°C

THERMAL RESISTANCE RATINGS

Parameter	Symbol	Channel 1		Channel 2		Unit
		Typical	Maximum	Typical	Maximum	
Maximum Junction-to-Ambient ^{b, d}	t ≤ 10 s	R _{thJA}	52	62.5	55	62.5
Maximum Junction-to-Foot (Drain)	Steady	R _{thJF}	32	40	40	50

Notes:

- a. Based on T_C = 25 °C.
- b. Surface mounted on 1" x 1" FR4 board.
- c. t = 10 s.
- d. Maximum under steady state conditions is 110 °C/W (Ch 1) and 120 °C/W (Ch 2).

SPECIFICATIONS $T_J = 25^\circ\text{C}$, unless otherwise noted

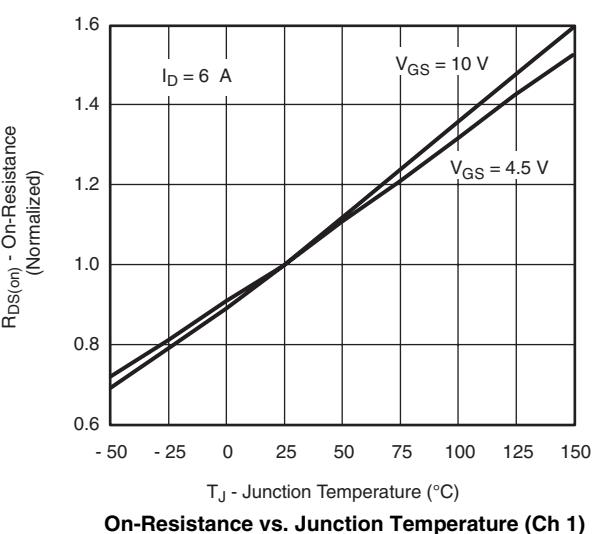
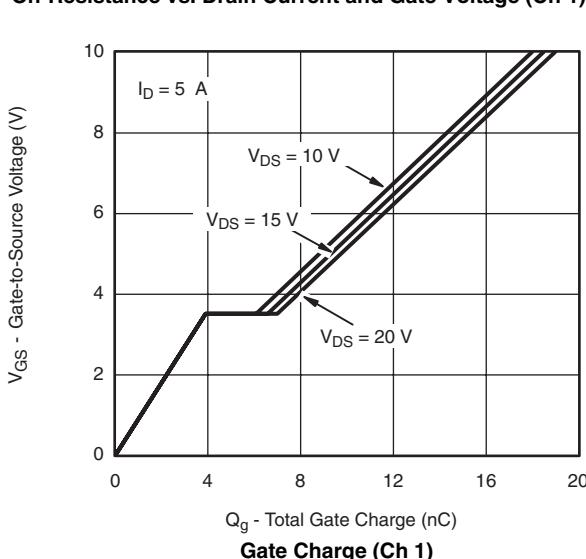
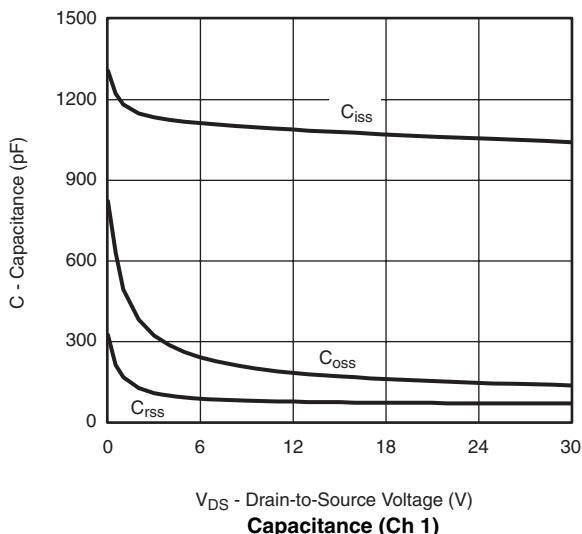
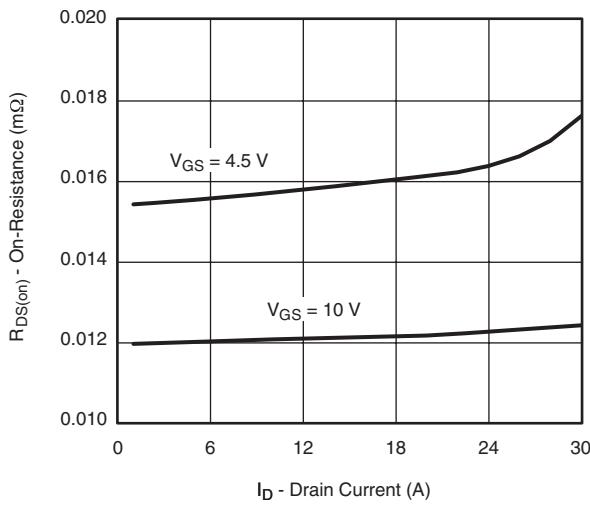
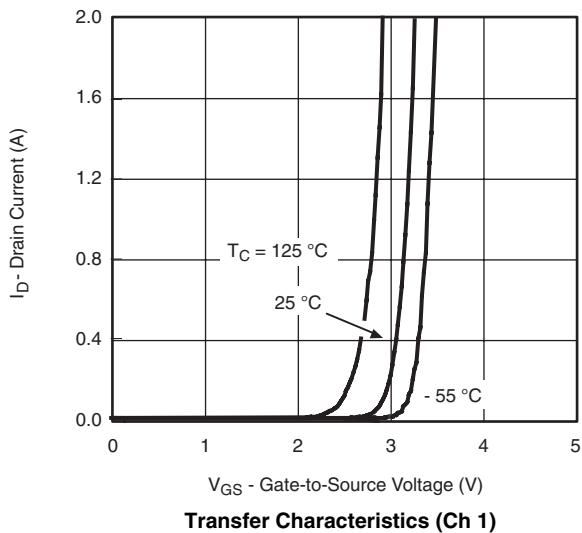
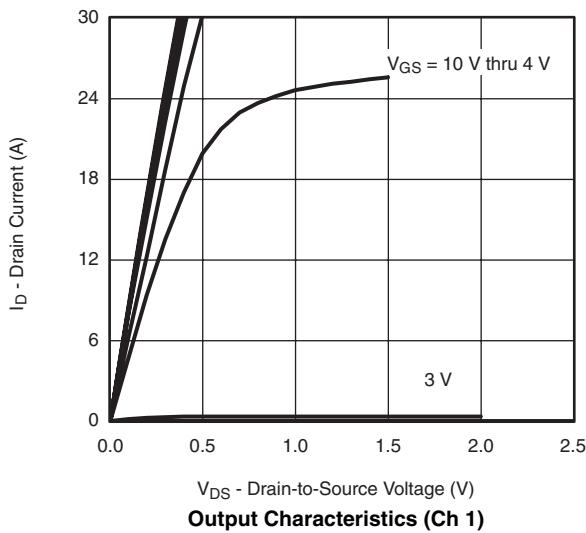
Parameter	Symbol	Test Conditions		Min.	Typ. ^a	Max.	Unit
Static							
Drain-Source Breakdown Voltage	V_{DS}	$V_{GS} = 0 \text{ V}$, $I_D = 250 \mu\text{A}$	Ch 1	30			V
		$V_{GS} = 0 \text{ V}$, $I_D = 250 \mu\text{A}$	Ch 2	30			
V_{DS} Temperature Coefficient	$\Delta V_{DS}/T_J$	$I_D = 250 \mu\text{A}$	Ch 1		35		mV/°C
		$I_D = 250 \mu\text{A}$	Ch 2		35		
$V_{GS(\text{th})}$ Temperature Coefficient	$\Delta V_{GS(\text{th})}/T_J$	$I_D = 250 \mu\text{A}$	Ch 1		- 6.5		mV/°C
		$I_D = 250 \mu\text{A}$	Ch 2		- 6.5		
Gate Threshold Voltage	$V_{GS(\text{th})}$	$V_{DS} = V_{GS}$, $I_D = 250 \mu\text{A}$	Ch 1	1.5		3.0	V
		$V_{DS} = V_{GS}$, $I_D = 250 \mu\text{A}$	Ch 2	1.5		3.0	
Gate-Body Leakage	I_{GSS}	$V_{DS} = 0 \text{ V}$, $V_{GS} = \pm 20 \text{ V}$	Ch 1			100	nA
			Ch 2			100	
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS} = 30 \text{ V}$, $V_{GS} = 0 \text{ V}$	Ch 1			1	μA
		$V_{DS} = 30 \text{ V}$, $V_{GS} = 0 \text{ V}$	Ch 2			1	
		$V_{DS} = 30 \text{ V}$, $V_{GS} = 0 \text{ V}$, $T_J = 55^\circ\text{C}$	Ch 1			10	
		$V_{DS} = 30 \text{ V}$, $V_{GS} = 0 \text{ V}$, $T_J = 55^\circ\text{C}$	Ch 2			10	
On-State Drain Current ^b	$I_{D(\text{on})}$	$V_{DS} = 5 \text{ V}$, $V_{GS} = 10 \text{ V}$	Ch 1	10			A
		$V_{DS} = 5 \text{ V}$, $V_{GS} = 10 \text{ V}$	Ch 2	10			
Drain-Source On-State Resistance ^b	$R_{DS(\text{on})}$	$V_{GS} = 10 \text{ V}$, $I_D = 6 \text{ A}$	Ch 1		0.012	0.0145	Ω
		$V_{GS} = 10 \text{ V}$, $I_D = 4.5 \text{ A}$	Ch 2		0.022	0.0265	
		$V_{GS} = 4.5 \text{ V}$, $I_D = 5.6 \text{ A}$	Ch 1		0.016	0.0195	
		$V_{GS} = 4.5 \text{ V}$, $I_D = 4 \text{ A}$	Ch 2		0.030	0.036	
Forward Transconductance ^b	g_{fs}	$V_{DS} = 15 \text{ V}$, $I_D = 6 \text{ A}$	Ch 1		27		S
		$V_{DS} = 15 \text{ V}$, $I_D = 4.5 \text{ A}$	Ch 2		20		
Dynamic^a							
Input Capacitance	C_{iss}	Channel 1 $V_{DS} = 15 \text{ V}$, $V_{GS} = 0 \text{ V}$, $f = 1 \text{ MHz}$	Ch 1		1080		pF
			Ch 2		515		
Output Capacitance	C_{oss}	Channel 2 $V_{DS} = 15 \text{ V}$, $V_{GS} = 0 \text{ V}$, $f = 1 \text{ MHz}$	Ch 1		170		
			Ch 2		91		
Reverse Transfer Capacitance	C_{rss}	Channel 1 $V_{DS} = 15 \text{ V}$, $V_{GS} = 0 \text{ V}$, $f = 1 \text{ MHz}$	Ch 1		72		
			Ch 2		38		
Total Gate Charge	Q_g	$V_{DS} = 15 \text{ V}$, $V_{GS} = 10 \text{ V}$, $I_D = 5 \text{ A}$	Ch 1		18.5	28	nC
		$V_{DS} = 15 \text{ V}$, $V_{GS} = 10 \text{ V}$, $I_D = 5 \text{ A}$	Ch 2		9.6	15	
Gate-Source Charge	Q_{gs}	Channel 1 $V_{DS} = 15 \text{ V}$, $V_{GS} = 4.5 \text{ V}$, $I_D = 5 \text{ A}$	Ch 1		8.3	13	
			Ch 2		4	6	
		Channel 2 $V_{DS} = 15 \text{ V}$, $V_{GS} = 4.5 \text{ V}$, $I_D = 5 \text{ A}$	Ch 1		3.9		
			Ch 2		1.9		
Gate-Drain Charge	Q_{gd}	$f = 1 \text{ MHz}$	Ch 1		2.7		
			Ch 2		1.3		
Gate Resistance	R_g			Ch 1	2.5	3.8	Ω
				Ch 2	2.9	4.4	

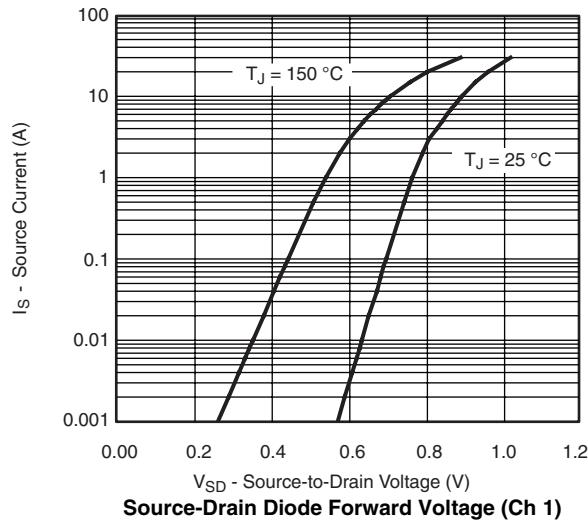
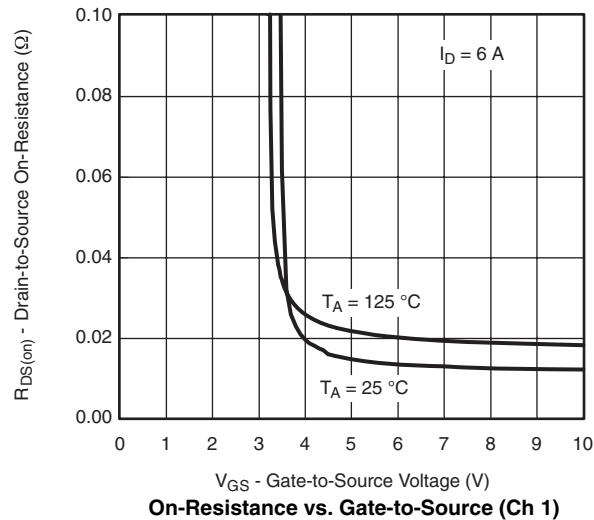
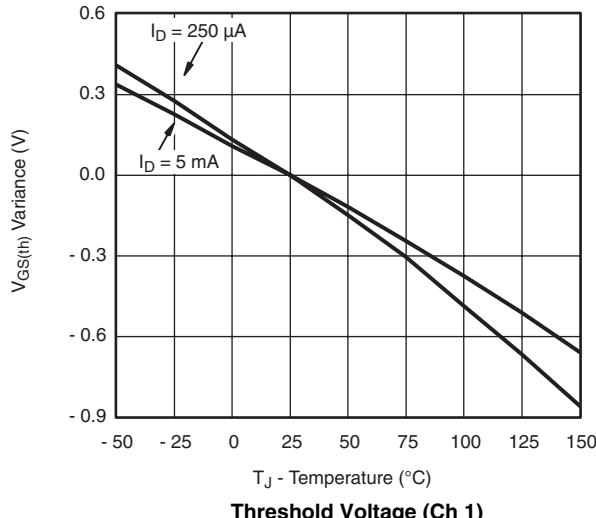
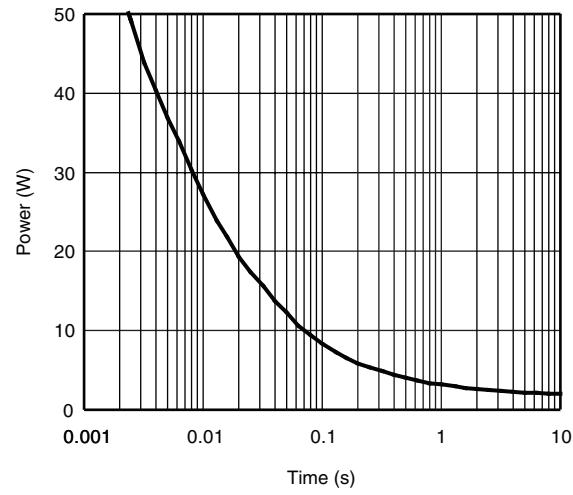
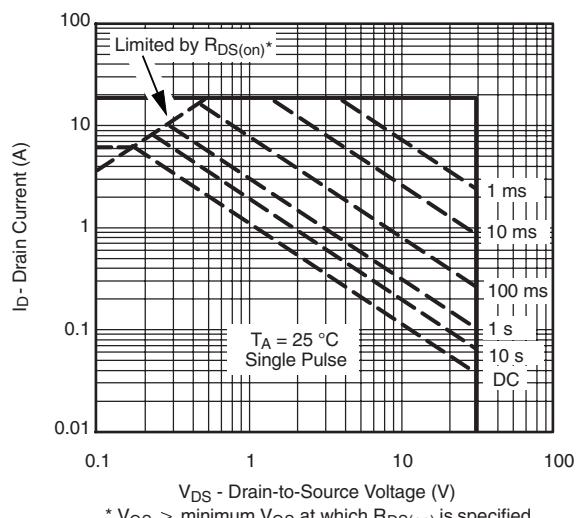
SPECIFICATIONS $T_J = 25^\circ\text{C}$, unless otherwise noted							
Parameter	Symbol	Test Conditions		Min.	Typ. ^a	Max.	Unit
Dynamic^a							
Turn-On Delay Time	$t_{d(on)}$	Channel 1 $V_{DD} = 15 \text{ V}$, $R_L = 3 \Omega$ $I_D \geq 5 \text{ A}$, $V_{GEN} = 10 \text{ V}$, $R_g = 1 \Omega$	Ch 1		12	18	ns
Rise Time	t_r		Ch 2		10	15	
Turn-Off Delay Time	$t_{d(off)}$		Ch 1		55	83	
Fall Time	t_f		Ch 2		60	90	
Turn-On Delay Time	$t_{d(on)}$		Ch 1		30	45	
Rise Time	t_r		Ch 2		22	33	
Turn-Off Delay Time	$t_{d(off)}$		Ch 1		7	11	
Fall Time	t_f		Ch 2		6	9	
Turn-On Delay Time	$t_{d(on)}$		Ch 1		120	180	
Rise Time	t_r		Ch 2		108	162	
Body Diode Characteristics							
Continous Source-Drain Diode Current	I_S	$T_C = 25^\circ\text{C}$		Ch 1		2.5	A
Pulse Diode Forward Current ^a	I_{SM}			Ch 2		2.1	
Body Diode Voltage	V_{SD}	$I_S = 1.6 \text{ A}$		Ch 1		20	
Body Diode Reverse Recovery Time	t_{rr}	$I_S = 1.6 \text{ A}$		Ch 2		20	
Body Diode Reverse Recovery Charge	Q_{rr}	Channel 1 $I_F = 2 \text{ A}$, $dI/dt = 100 \text{ A}/\mu\text{s}$, $T_J = 25^\circ\text{C}$		Ch 1		21	nC
Reverse Recovery Fall Time	t_a			Ch 2		18	
Reverse Recovery Rise Time	t_b	Channel 2 $I_F = 2 \text{ A}$, $dI/dt = 100 \text{ A}/\mu\text{s}$, $T_J = 25^\circ\text{C}$		Ch 1		15	
				Ch 2		11	

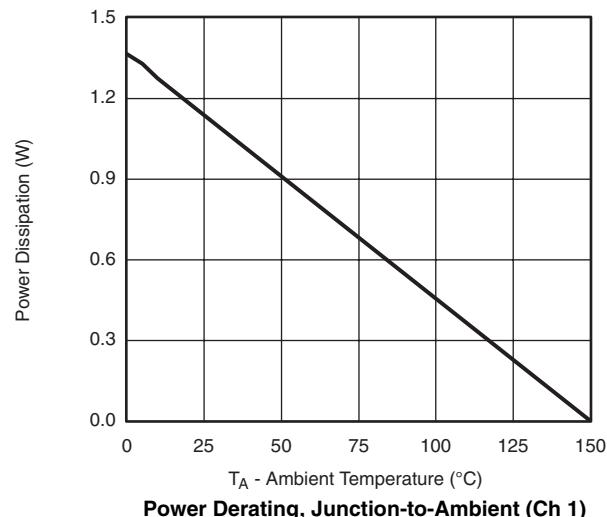
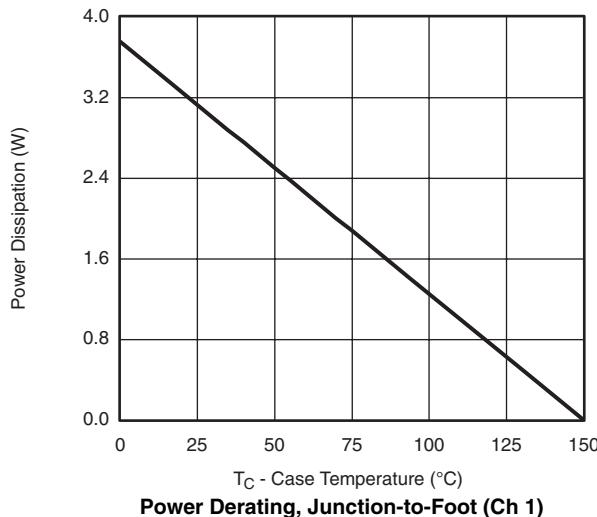
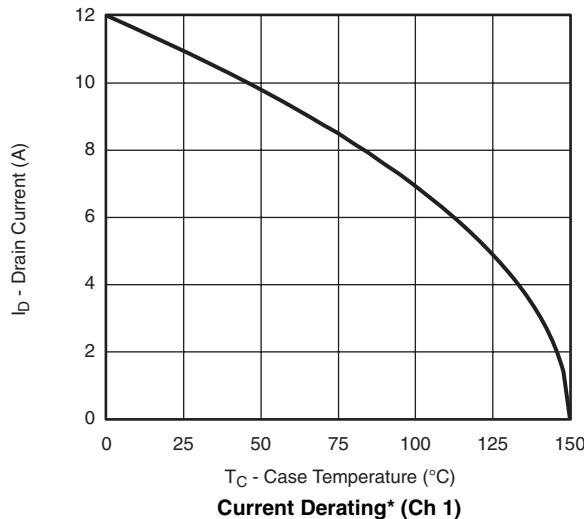
Notes:

- a. Guaranteed by design, not subject to production testing.
- b. Pulse test; pulse width $\leq 300 \mu\text{s}$, duty cycle $\leq 2\%$.

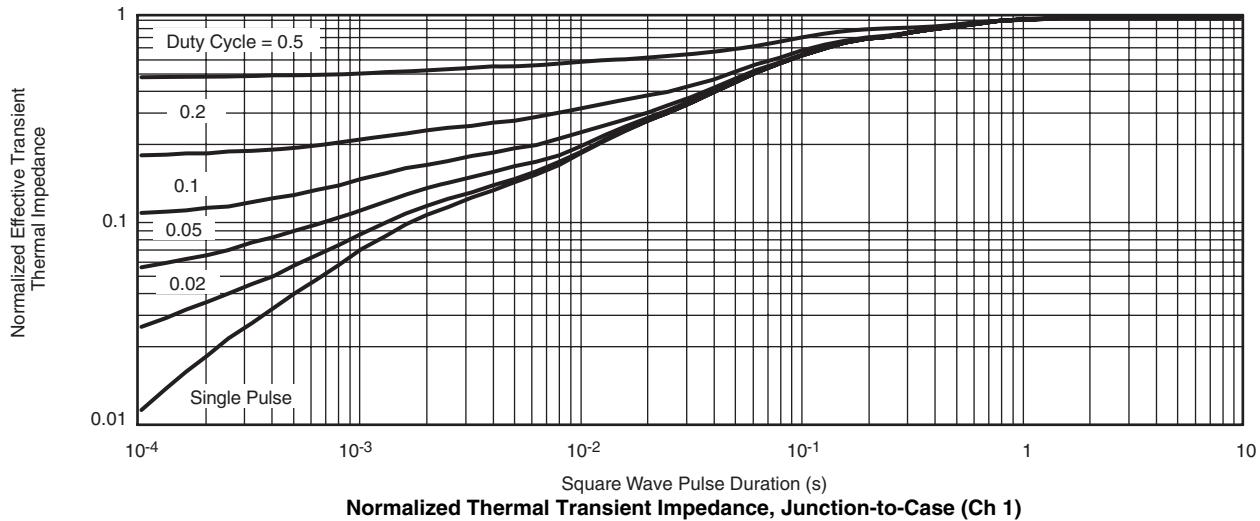
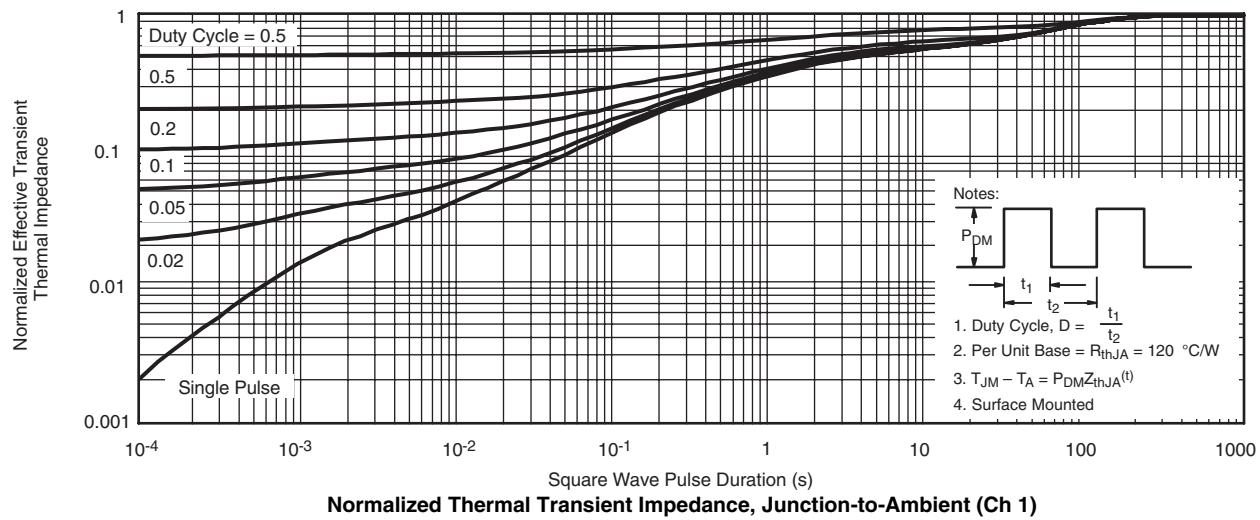
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

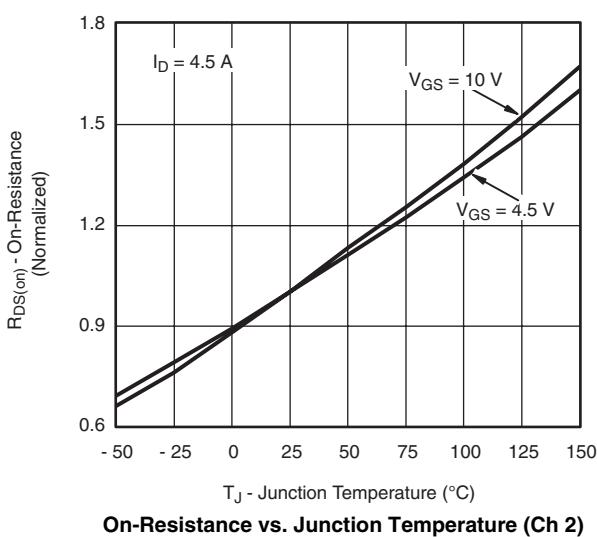
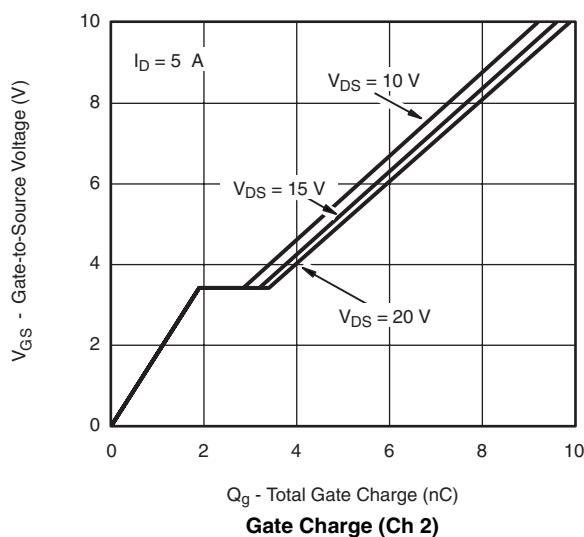
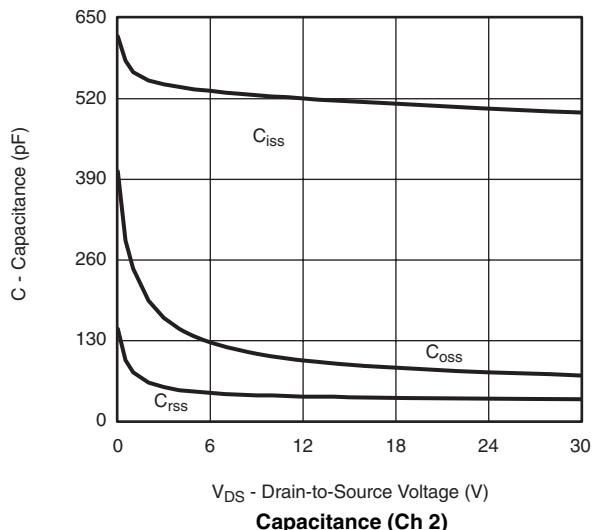
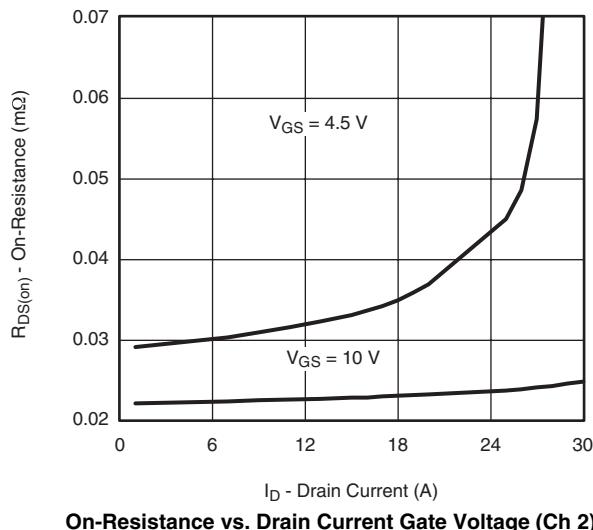
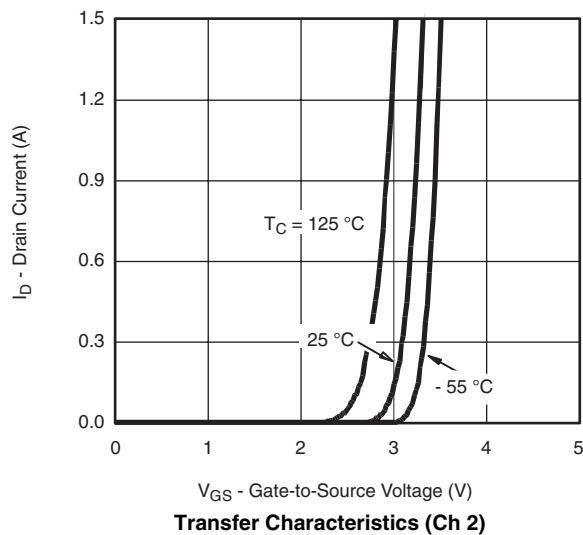
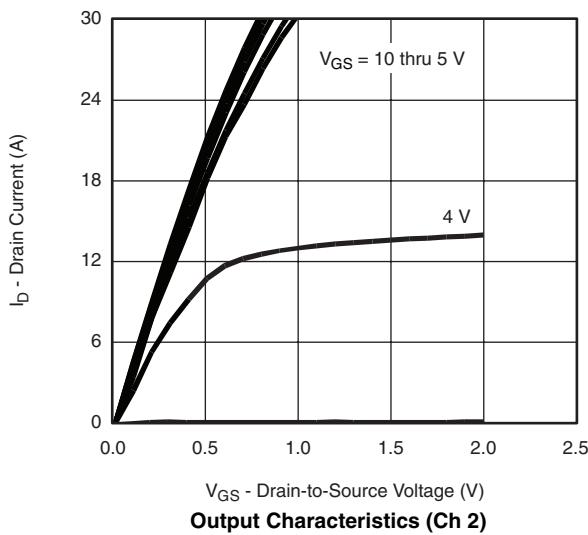
TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

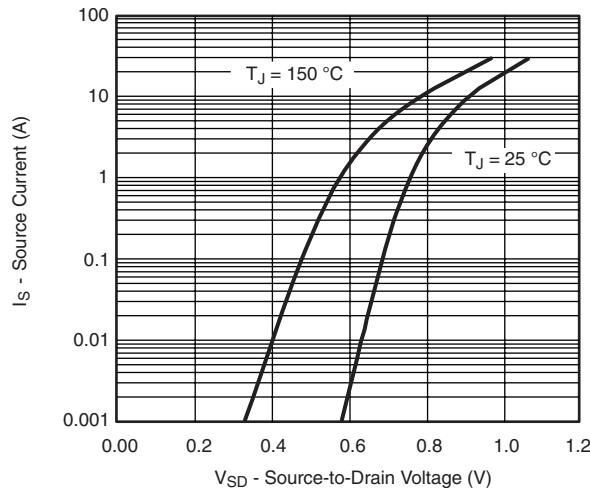
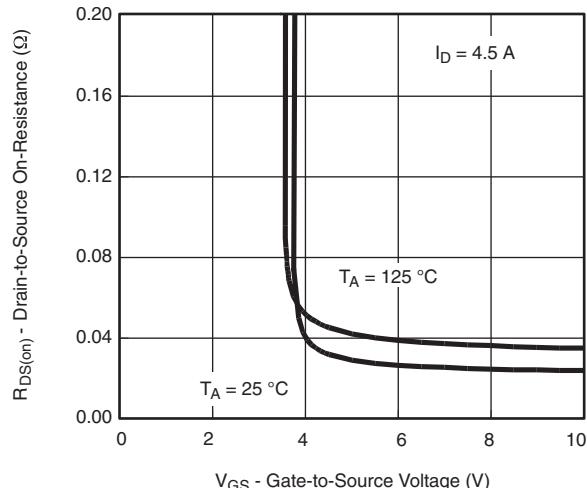
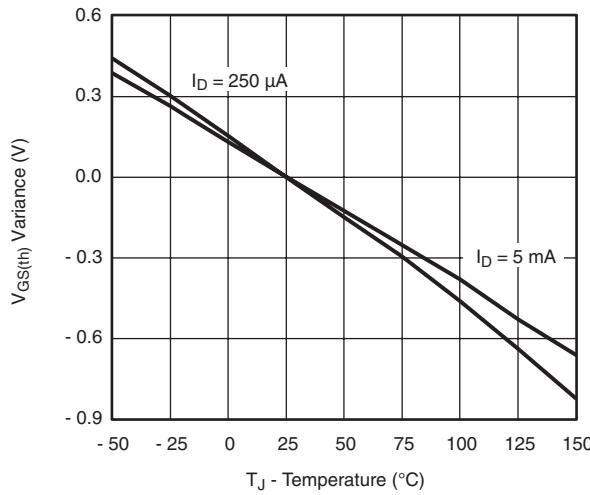
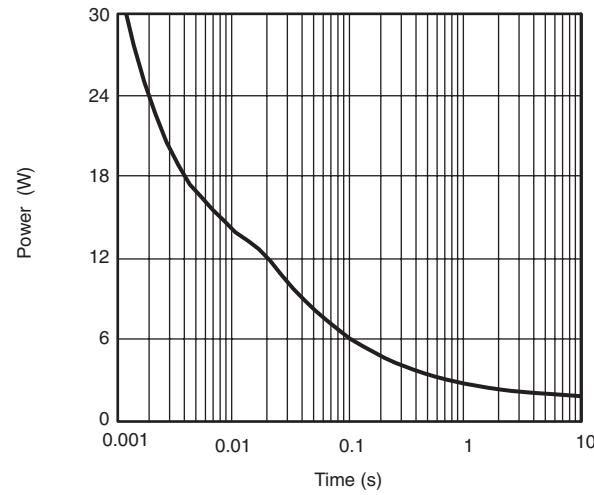
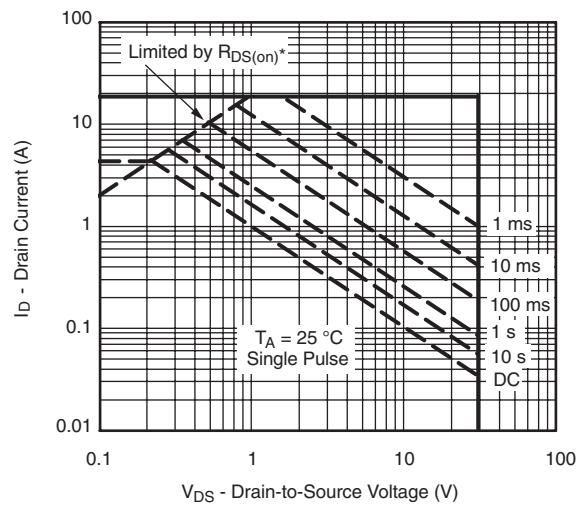
TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

Source-Drain Diode Forward Voltage (Ch 1)

On-Resistance vs. Gate-to-Source (Ch 1)

Threshold Voltage (Ch 1)

Single Pulse Power, Junction-to-Ambient (Ch 1)

Safe Operating Area, Junction-to-Ambient (Ch 1)
* $V_{GS} >$ minimum V_{GS} at which $R_{DS(on)}$ is specified

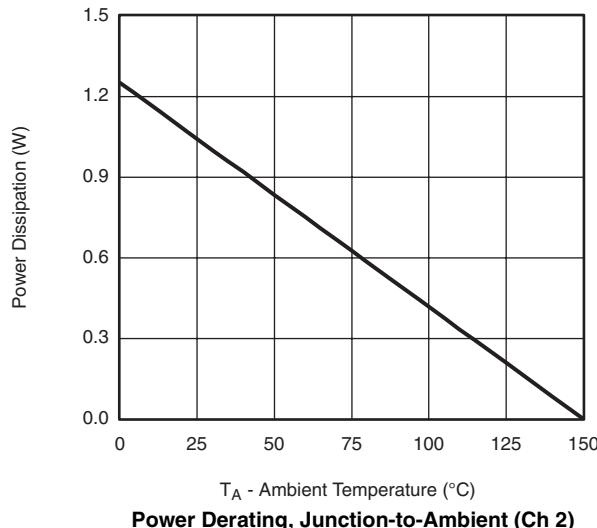
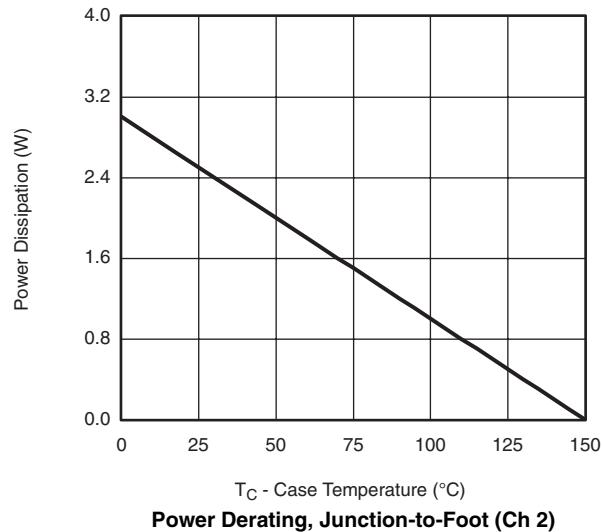
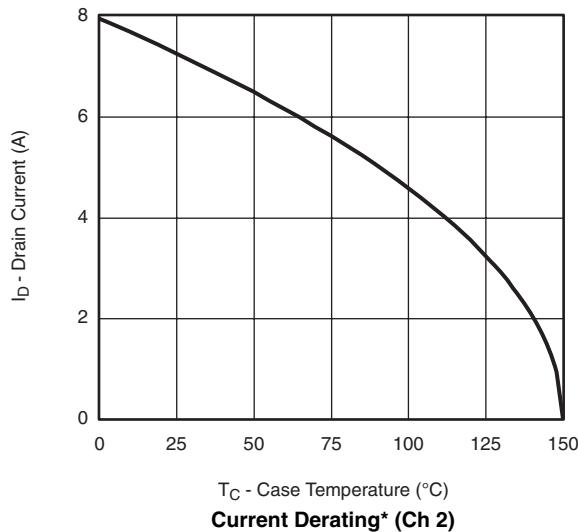
TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

* The power dissipation P_D is based on T_{J(max)} = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

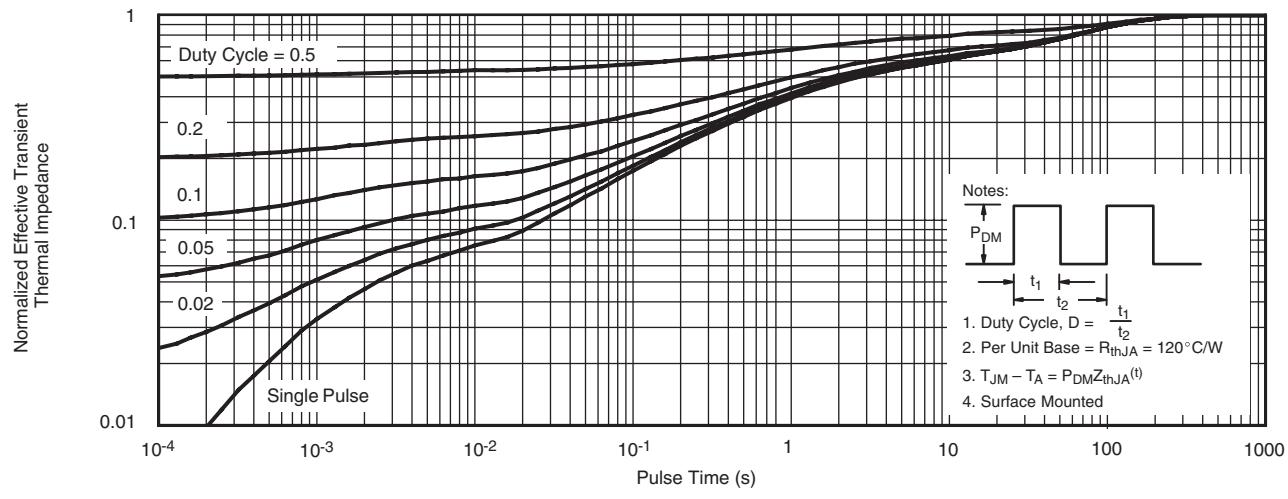
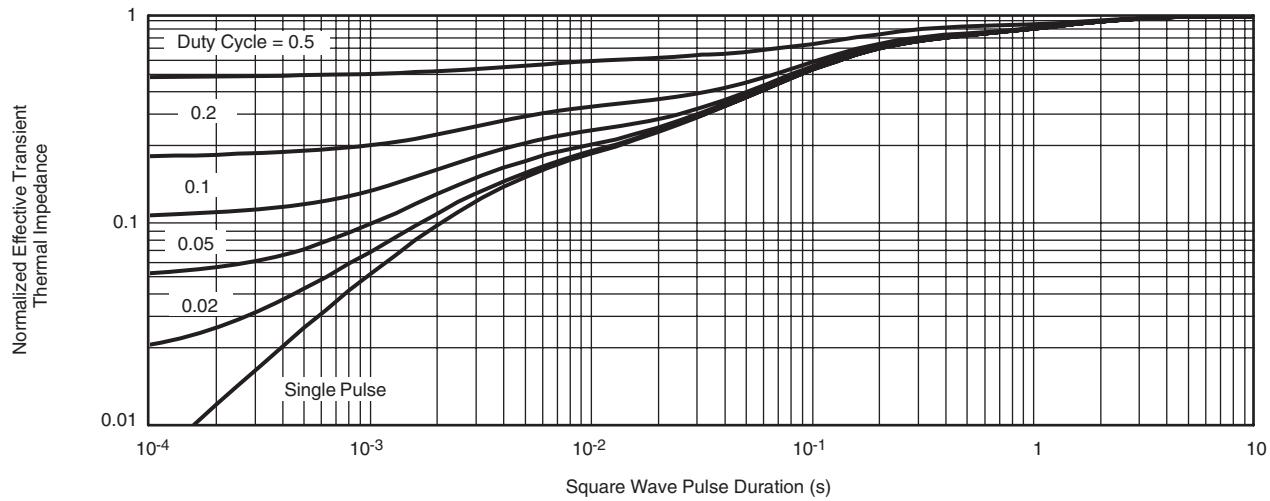
TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted


TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

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Source-Drain Diode Forward Voltage (Ch 2)

On-Resistance vs. Gate-to-Source Temperature (Ch 2)

Threshold Voltage (Ch 2)

Single Pulse Power, Junction-to-Ambient (Ch 2)

 $* V_{GS} > \text{minimum } V_{GS} \text{ at which } R_{DS(on)} \text{ is specified}$
Safe Operating Area, Junction-to-Ambient (Ch 2)

TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

* The power dissipation P_D is based on $T_{J(\max)} = 150$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

Normalized Thermal Transient Impedance, Junction-to-Ambient (Ch 2)

Normalized Thermal Transient Impedance, Junction-to-Case (Ch 2)

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